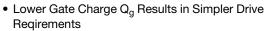


### **SVF840T-VB Datasheet**

### N-Channel 500V (D-S)Power MOSFET

| PRODUCT SUMMARY            |                        |       |  |  |  |
|----------------------------|------------------------|-------|--|--|--|
| V <sub>DS</sub> (V)        | 500                    |       |  |  |  |
| $R_{DS(on)}(\Omega)$       | V <sub>GS</sub> = 10 V | 0.660 |  |  |  |
| Q <sub>g</sub> (Max.) (nC) | 81                     |       |  |  |  |
| Q <sub>gs</sub> (nC)       | 20                     |       |  |  |  |
| Q <sub>gd</sub> (nC)       | 36                     |       |  |  |  |
| Configuration              | Single                 |       |  |  |  |

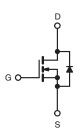
#### **FEATURES**





- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage
- Compliant to RoHS Directive 2002/95/EC





N-Channel MOSFET

| PARAMETER  |  |   | SYMBOL                            | LIMIT            | UNIT     |  |
|--|--|---|-----------------------------------|------------------|----------|--|
| Drain-Source Voltage                             |  |   | $V_{DS}$                          | 500              | V        |  |
| Gate-Source Voltage                              |  |   | $V_{GS}$                          | ± 20             |          |  |
| Continuous Drain Current                         | V <sub>GS</sub> at 10 V                        | T <sub>C</sub> = 25 °C                        | - I <sub>D</sub>                  | 13               |          |  |
|  |  | $T_C = 25 ^{\circ}C$<br>$T_C = 100 ^{\circ}C$ |                                   | 8.1              | А        |  |
| Pulsed Drain Current <sup>a</sup>                |  |   | I <sub>DM</sub>                   | 50               |          |  |
| Linear Derating Factor                           |  |   |                                   | 2.0              | W/°C     |  |
| Single Pulse Avalanche Energy <sup>b</sup>       |  |   | E <sub>AS</sub>                   | 560              | mJ       |  |
| Avalanche Current <sup>a</sup>                   |  |   | I <sub>AR</sub>                   | 13               | А        |  |
| Repetitive Avalanche Energy <sup>a</sup>         |  |   | E <sub>AR</sub>                   | 25               | mJ       |  |
| Maximum Power Dissipation                        | ximum Power Dissipation T <sub>C</sub> = 25 °C |   |                                   | 250              | W        |  |
| Peak Diode Recovery dV/dt <sup>c</sup>           |  |   | dV/dt                             | 9.2              | V/ns     |  |
| Operating Junction and Storage Temperature Range |  |   | T <sub>J</sub> , T <sub>stg</sub> | - 55 to + 150    | °C       |  |
| Soldering Recommendations (Peak Temperature)     | for  | 10 s  |                                   | 300 <sup>d</sup> |          |  |
| Mounting Torque                                  | 6-32 or M3 screw                               |   |                                   | 10               | lbf ⋅ in |  |
| Mounting Torque                                  |  |   |                                   | 1.1              | N⋅m      |  |

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T<sub>J</sub> = 25 °C, L = 5.7 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> =14 A, dV/dt = 7.6 V/ns (see fig. 12a). c. I<sub>SD</sub>  $\leq$  14 A, dI/dt  $\leq$  250 A/µs, V<sub>DD</sub>  $\leq$  V<sub>DS</sub>, T<sub>J</sub>  $\leq$  150 °C.
- d. 1.6 mm from case.



| THERMAL RESISTANCE RATINGS         |                   |      |      |      |  |  |
|------------------------------------|-------------------|------|------|------|--|--|
| PARAMETER                          | SYMBOL            | TYP. | MAX. | UNIT |  |  |
| Maximum Junction-to-Ambient        | R <sub>thJA</sub> | -    | 62   |      |  |  |
| Case-to-Sink, Flat, Greasd Surface | R <sub>thCS</sub> | 0.50 | -    | °C/W |  |  |
| Maximum Junction-to-Case (Drain)   | R <sub>thJC</sub> | -    | 0.50 |      |  |  |

| PARAMETER                                 | SYMBOL                | TEST CONDITIONS  |  | MIN.      | TYP.                 | MAX.             | UNIT  |  |
|---|-----------------------|--|--|-----------|----------------------|------------------|-------|--|
| Static                                    |                       |  |  |           | •                    |                  |       |  |
| Drain-Source Breakdown Voltage            | V <sub>DS</sub>       | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$  |  | 500       | -                    | -                | V     |  |
| V <sub>DS</sub> Temperature Coefficient   | $\Delta V_{DS}/T_{J}$ | Reference  | ce to 25 °C, I <sub>D</sub> = 1 mA   | -         | 0.55                 | -                | V/°C  |  |
| Gate-Source Threshold Voltage             | V <sub>GS(th)</sub>   | V <sub>DS</sub> =  | = V <sub>GS</sub> , I <sub>D</sub> = 250 μA  | 2.0       | -                    | 4.0              | V     |  |
| Gate-Source Leakage                       | I <sub>GSS</sub>      |  | $V_{GS} = \pm 20V$   | -         | -                    | ±100             | nA    |  |
| Zero Gate Voltage Drain Current           | l                     | V <sub>DS</sub> =  | = 500 V, V <sub>GS</sub> = 0 V   | -         | -                    | 25               | ,     |  |
| Zero Gate Voltage Drain Current           | I <sub>DSS</sub>      | V <sub>DS</sub> = 400 \  | /, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C  | -         | -                    | 250              | μA    |  |
| Drain-Source On-State Resistance          | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V   | $I_D = 8.4 A^b$  | -         | 0.660                | -                | Ω     |  |
| Forward Transconductance                  | g <sub>fs</sub>       | V <sub>DS</sub>  | = 50 V, I <sub>D</sub> = 8.4 A   | 8.1       | -                    | -                | S     |  |
| Dynamic                                   |                       |  |  |           |                      |                  |       |  |
| Input Capacitance                         | C <sub>iss</sub>      |  | $V_{GS} = 0 V$   | -         | 1910                 | -                |       |  |
| Output Capacitance                        | C <sub>oss</sub>      | 1  | $V_{DS} = 25 \text{ V},$   |           | 290                  | -                | 1     |  |
| Reverse Transfer Capacitance              | C <sub>rss</sub>      | f = 1  | .0 MHz, see fig. 5   | -         | 11                   | -                | pF    |  |
| Output Conscitones                        | C <sub>oss</sub>      |  | V <sub>DS</sub> = 1.0 V, f = 1.0 MHz   | -         | 2730                 | -                |       |  |
| Output Capacitance                        |                       | V <sub>GS</sub> = 0 V  | V <sub>DS</sub> = 400 V, f = 1.0 MHz   | -         | 82                   | -                |       |  |
| Effective Output Capacitance              | C <sub>oss</sub> eff. | V <sub>DS</sub> = 0 V to 400 V <sup>c</sup>  |  | -         | 160                  | -                |       |  |
| Total Gate Charge                         | Qg                    |  |  | -         | -                    | 81               |       |  |
| Gate-Source Charge                        | Q <sub>gs</sub>       | I <sub>D</sub> = 14 A, V <sub>DS</sub> = 400 V, see fig. 6 and 13 <sup>b</sup>                           |  | -         | -                    | 20               | nC    |  |
| Gate-Drain Charge                         | $Q_{gd}$              | 1  | See lig. 0 and 15  |           | -                    | 36               |       |  |
| Turn-On Delay Time                        | t <sub>d(on)</sub>    | V <sub>GS</sub> = 10 V   |  | -         | 15                   | -                | ns ns |  |
| Rise Time                                 | t <sub>r</sub>        |  | $V_{DD} = 250 \text{ V, } I_D = 14 \text{ A,} \ R_g = 7.5 \Omega, \ \text{see fig. } 10^b$ |           | 39                   | -                |       |  |
| Turn-Off Delay Time                       | t <sub>d(off)</sub>   |  |  |           | 39                   | -                |       |  |
| Fall Time                                 | t <sub>f</sub>        |  |  | -         | 31                   | -                |       |  |
| Drain-Source Body Diode Characteristic    | cs                    |  | <u> </u>   |           |                      |                  |       |  |
| Continuous Source-Drain Diode Current     | Is                    | MOSFET sym   | MOSFET symbol showing the  |           | -                    | 13               | A     |  |
| Pulsed Diode Forward Current <sup>a</sup> | I <sub>SM</sub>       | integral reverse p - n junction diode  |  | -         | -                    | 56               |       |  |
| Body Diode Voltage                        | V <sub>SD</sub>       | T <sub>J</sub> = 25 °C, I <sub>S</sub> = 14 A, V <sub>GS</sub> = 0 V <sup>b</sup>                        |  | -         | -                    | 1.5              | V     |  |
| Body Diode Reverse Recovery Time          | t <sub>rr</sub>       | T <sub>J</sub> = 25 °C, I <sub>F</sub> = 14 A,<br>T <sub>J</sub> = 125 °C, dl/dt = 100 A/μs <sup>b</sup> |  | -         | 370                  | 550              | ns    |  |
| Body Diode Reverse Recovery Charge        | Q <sub>rr</sub>       |  |  | -         | 4.4                  | 6.5              | μC    |  |
| Body Diode Reverse Recovery Current       | I <sub>RRM</sub>      |  |  | -         | 21                   | 31               | Α     |  |
| Forward Turn-On Time                      | t <sub>on</sub>       | Intrinsic tu   | on is dor  | ninated b | v L <sub>s</sub> and | L <sub>D</sub> ) |       |  |

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s$ ; duty cycle  $\leq 2~\%$ .
- c.  $C_{oss}$  eff. is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DS}$ .



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

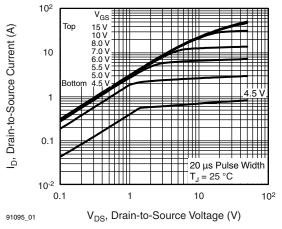


Fig. 1 - Typical Output Characteristics

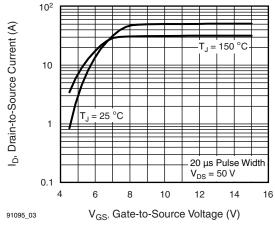


Fig. 3 - Typical Transfer Characteristics

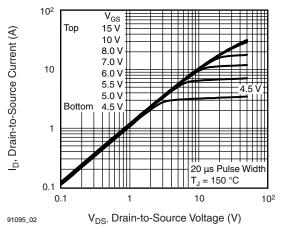


Fig. 2 - Typical Output Characteristics

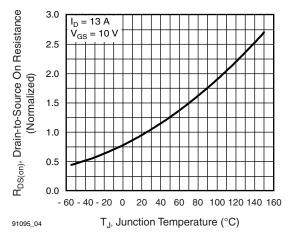


Fig. 4 - Normalized On-Resistance vs. Temperature



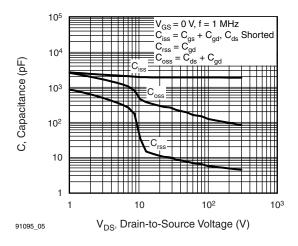


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

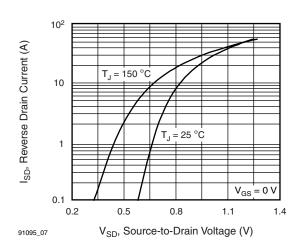


Fig. 7 - Typical Source-Drain Diode Forward Voltage

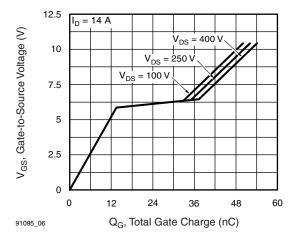


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

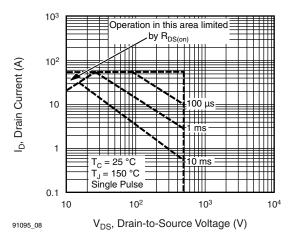


Fig. 8 - Maximum Safe Operating Area



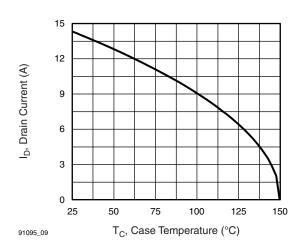


Fig. 9 - Maximum Drain Current vs. Case Temperature

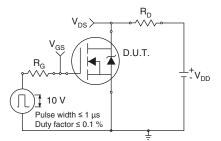


Fig. 10a - Switching Time Test Circuit

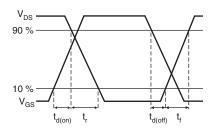


Fig. 10b - Switching Time Waveforms

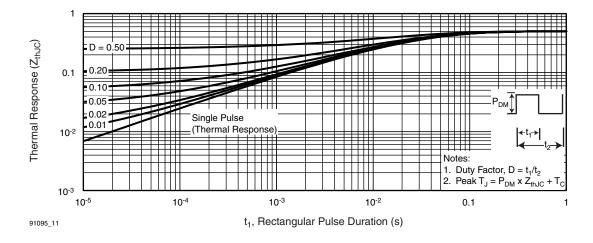
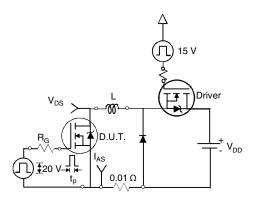
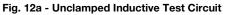


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case







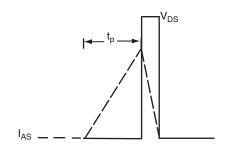


Fig. 12b - Unclamped Inductive Waveforms

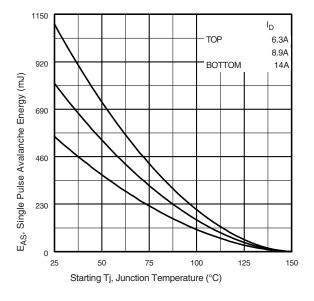


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

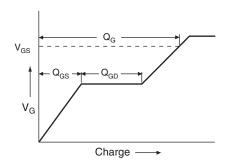


Fig. 13a - Basic Gate Charge Waveform

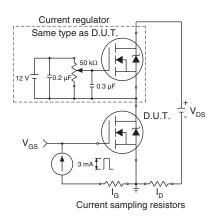
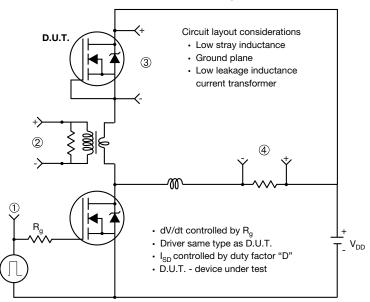


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



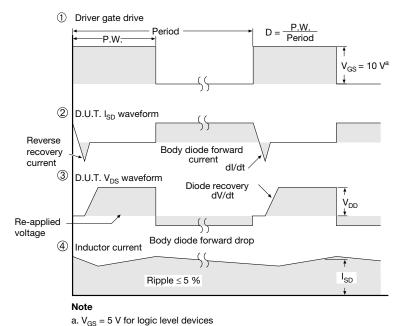
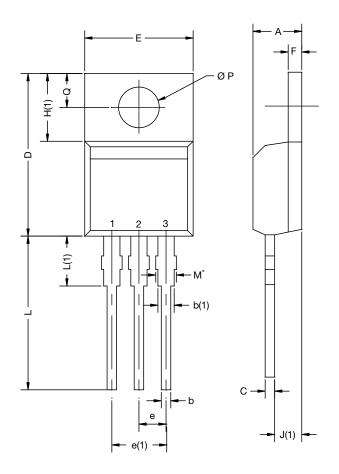


Fig. 14 - For N-Channel



## **TO-220AB**



| DIM.   | MILLIM | IETERS | INCHES |       |  |
|--|--------|--------|--------|-------|--|
|  | MIN.   | MAX.   | MIN.   | MAX.  |  |
| А  | 4.24   | 4.65   | 0.167  | 0.183 |  |
| b  | 0.69   | 1.02   | 0.027  | 0.040 |  |
| b(1)   | 1.14   | 1.78   | 0.045  | 0.070 |  |
| С  | 0.36   | 0.61   | 0.014  | 0.024 |  |
| D  | 14.33  | 15.85  | 0.564  | 0.624 |  |
| Е  | 9.96   | 10.52  | 0.392  | 0.414 |  |
| е  | 2.41   | 2.67   | 0.095  | 0.105 |  |
| e(1)   | 4.88   | 5.28   | 0.192  | 0.208 |  |
| F  | 1.14   | 1.40   | 0.045  | 0.055 |  |
| H(1)   | 6.10   | 6.71   | 0.240  | 0.264 |  |
| J(1)   | 2.41   | 2.92   | 0.095  | 0.115 |  |
| L  | 13.36  | 14.40  | 0.526  | 0.567 |  |
| L(1)   | 3.33   | 4.04   | 0.131  | 0.159 |  |
| ØР   | 3.53   | 3.94   | 0.139  | 0.155 |  |
| Q  | 2.54   | 3.00   | 0.100  | 0.118 |  |
| ECN: X15-0364-Rev. C, 14-Dec-15<br>DWG: 6031 |        |        |        |       |  |

#### Note

 $\bullet~M^{\star}=0.052$  inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



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